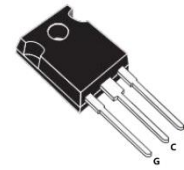


Features

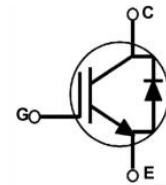
- Low gate charge.
- Trench FS Technology
- Saturation Voltage:
 $V_{CE(sat)} = 1.8V @ I_C = 40 A$
- RoHS Complaint



TO-247

Applications

- General purpose inverters
- UPS



Absolute Maximum Ratings

Parameter		Symbol	Value	Unit
Collector to Emitter Voltage		V_{CES}	1200	V
Gate to Emitter Voltage		V_{GES}	± 20	
Turn-off safe area		-	160	A
Collector Current	$T_C = 25^\circ C$	I_C	80	A
	$T_C = 100^\circ C$		40	
Pulsed Collector Current $T_C = 25^\circ C$		I_{CM}	160	
Diode forward current @ $T_C = 100^\circ C$		I_F	40	
Maximum Power Dissipation $T_C = 25^\circ C$		P_D	718	W
Operating Junction Temperature		T_J	-55 to 175	$^\circ C$
Storage Temperature Range		T_{stg}	-55 to 150	
Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		T_L	300	

*Collector current limited by maximum junction temperature

Notes: 1: Pulse width limited by maximum junction temperature

Thermal Characteristics

Parameter	Symbol	Typ	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.209	$^\circ C/W$
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	34.09	

Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

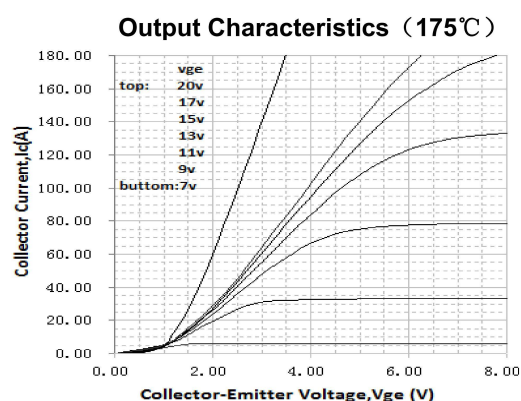
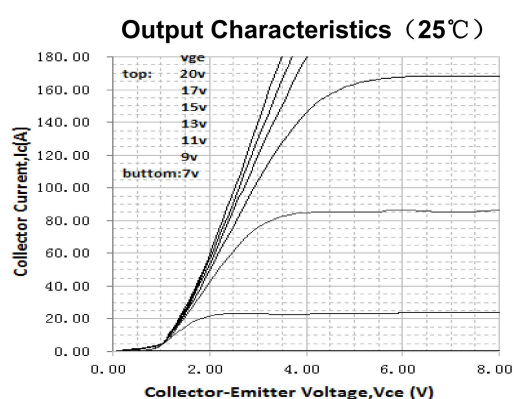
Parameter	Symbol		Test Conditions	Min	Type	Max	Unit
On/off Characteristics							
Collector to Emitter Breakdown Voltage	BV _{CES}		V _{GE} = 0V, I _C = 250μ	1200	-	-	V
Breakdown Voltage Temperature Coefficient	ΔBV _{CES} /ΔT _J		IC=0.5mA, referenced to 25℃	-	0.6	-	V/℃
Zero Gate Voltage Collector Current	I _{CES}		VCE=1200V, VGE=0V, TC=25℃	-	-	0.2	mA
			VCE=1200V, VGE=0V, TC=175℃	-	-	2	
Gate-body leakage current, forward	I _{GESF}		VCE=0V, VGE =20V	-	-	200	nA
Gate-body leakage current, reverse	I _{GESR}		VCE=0V, VGE =-20V	-	-	-200	nA
On-Characteristics							
Gate Threshold Voltage	V _{TH}		VCE =VGE , IC=250μA	4.5	-	6.5	V
Collector-Emmitter saturation Voltage	V _{CESAT}		V _{GE} =15V I _C =40A T _c =25℃	-	1.8	2.0	V
			V _{GE} =15V I _C =40A T _c =175℃	-	2.4	-	V
Dynamic Characteristics							
Input Capacitance	C _{ies}		VCE = 25V, VGE = 0V f = 1MHz	-	4604	-	pF
Output Capacitance	C _{oes}			-	200	-	
Reverse Transfer Capacitance	C _{res}			-	49	-	
Switching Characteristics							
Turn-On Delay Time	td(on)		VCC = 600V, IC = 40A, RG = 12Ω, VGE = 15V, Parasitic ductance = 75nH TC=25℃	-	56	-	nS
Rise Tim	tr			-	98	-	
Turn-Off Delay Tim	td(off)			-	208	-	
Fall Time	tf			-	176	-	
Turn-On energy	Eon			-	2.10	-	
Turn-off energy	Eoff			-	2.28	-	
Total switching energy	Etot			-	4.38	-	
Turn-On Delay Time	td(on)		VCC = 600V, IC = 40A,	-	50	-	
Rise Tim	tr		RG = 12Ω, VGE = 15V,	-	98	-	
Turn-Off Delay Tim	td(off)		Parasitic ductance =	-	252	-	

Fall Time	tf	75nH TC=175°C	-	322	-	
Turn-On energy	Eon		-	2.24	-	
Turn-off energy	Eoff		-	3.48	-	
Total switching energy	Etot		-	5.72	-	
Total Gate Charge	Qg	VCC = 960V, IC = 40A, VGE = 15V	-	165	-	nC
Gate to Emitter Charge	Qge		-	46	-	
Gate to Collector Charge	Qgc		-	69	-	

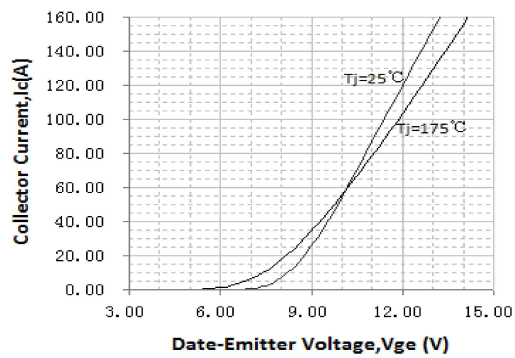
Electrical Characteristics of the Diode $T_C = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Test Conditions		Min	Type	Max	Unit
Diode Forward Voltage	V _{FM}	I _F = 40A		-	2.3	3.0	V
Diode Reverse Recovery Time	t _{rr}	I _F =40A, di _F /dt = 200A/μs	T _C =25℃	-	376	-	ns
			T _C =125℃	-	618	-	
Diode Peak Reverse Recovery Cyrrent	I _{rr}		T _C =25℃	-	6.5	-	A
			T _C =125℃	-	13.3	-	
Diode Reverse Recovery Charge	Q _{rr}		T _C =25℃	-	1311	-	nC
			T _C =125℃	-	4283	-	

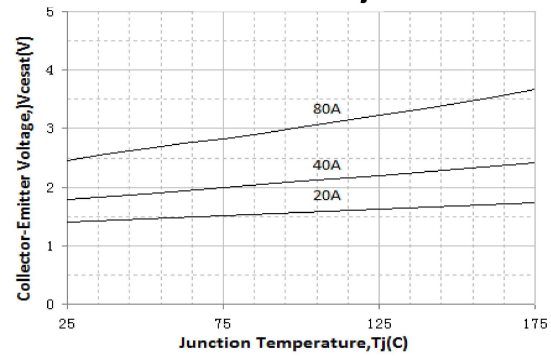
Typical Performance Characteristics



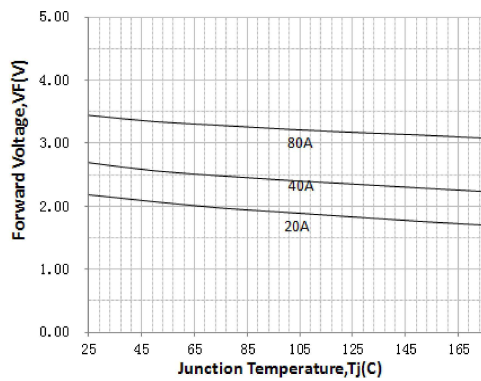
Transfer Characteristics



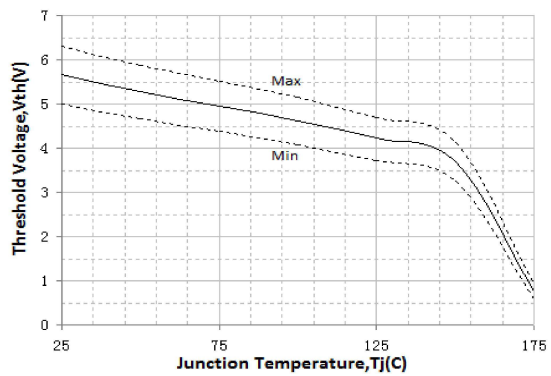
Vcesat vs. Tj



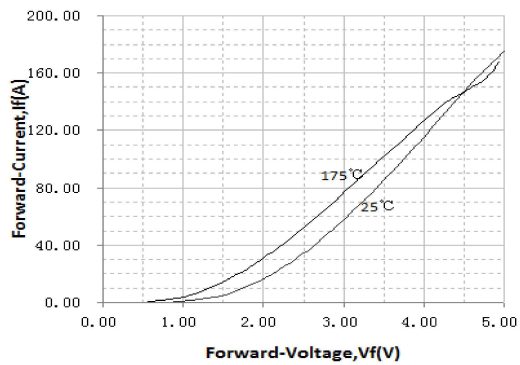
VF vs. Tj



VTH vs. Tj

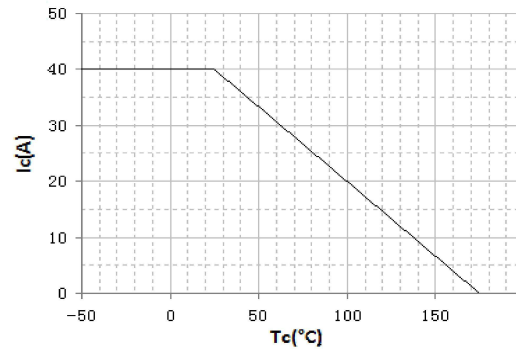


Diode Characteristic



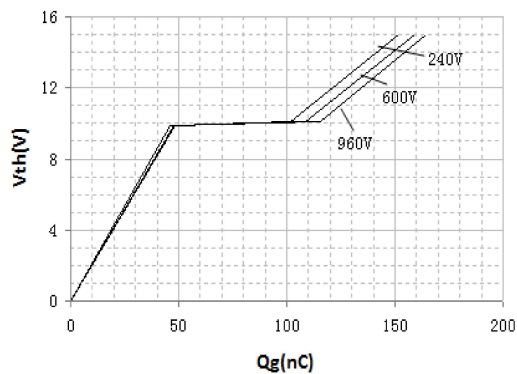
Collector current vs. case temperature

$V_{GE} \geq 15\text{V}$, $T_j \leq 175^\circ\text{C}$



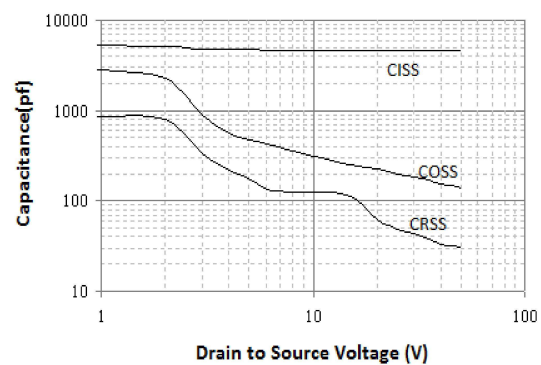
Gate Charge Characteristics

$V_{GE} = 15\text{V}$, $I_c = 40\text{A}$

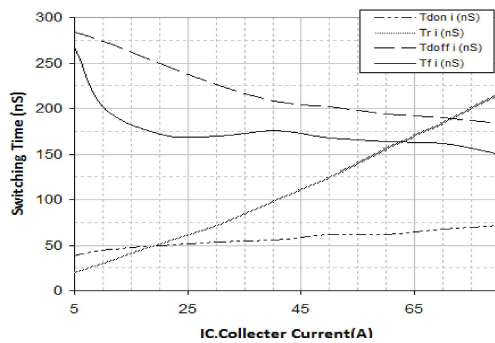


Capacitance Characteristic

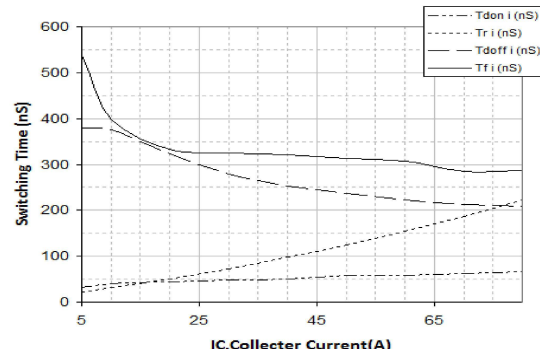
$V_{ce} = 25\text{V}$, $V_{GE} = 0\text{V}$, $f = 1.0\text{MHz}$



Switching Time vs. IC(25°C)

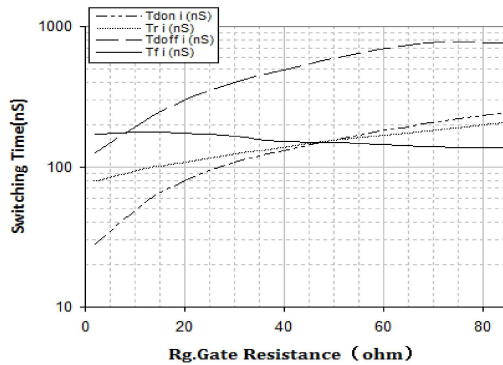


Switching Time vs. IC(175°C)



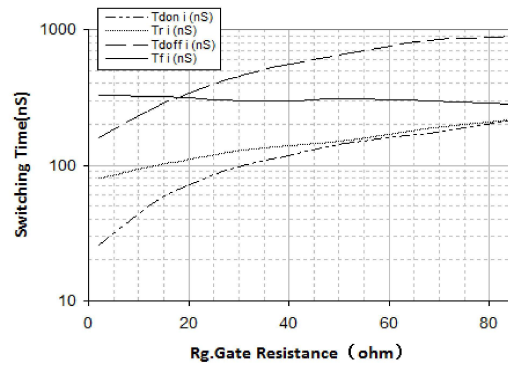
Switching Time vs. Rg(25°C)

VGE=15V, VCE=600V, IC=40A



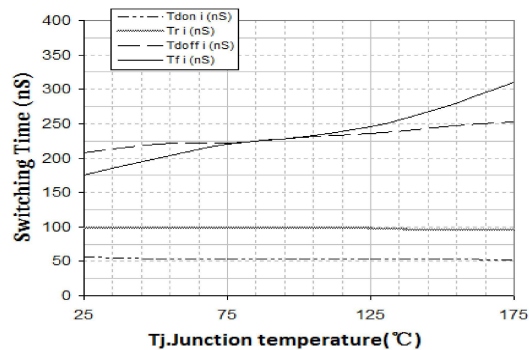
Switching Time vs. Rg(175°C)

VGE=15V, VCE=600V, IC=40A



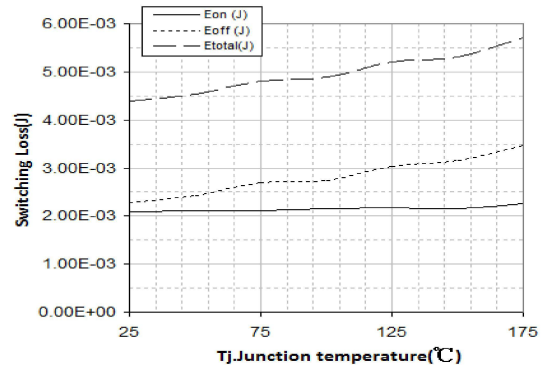
Switching Time vs. Tj

VGE=15V, VCE=600V, IC=40A, Rg=12Ω



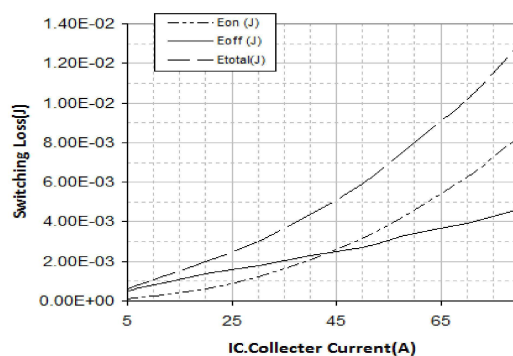
Switching Loss vs. Tj

VGE=15V, VCE=600V, IC=40A, Rg=12Ω



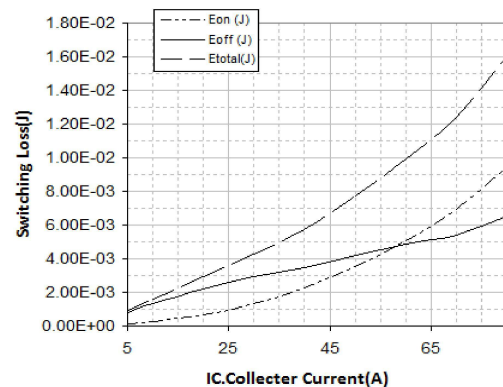
Switching Loss vs. IC(25°C)

VGE=15V, VCE=600V, Rg=12Ω



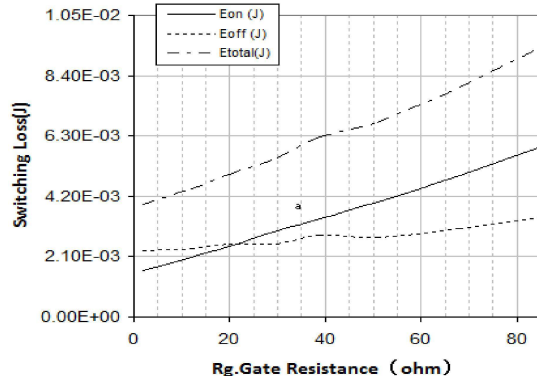
Switching Loss vs. IC(175°C)

VGE=15V, VCE=600V, Rg=12Ω



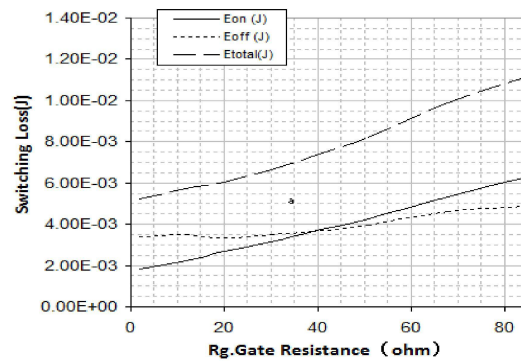
Switching Loss vs. $R_g(25^\circ\text{C})$

$V_{GE}=15\text{V}, V_{CE}=600\text{V}, I_C=40\text{A}$



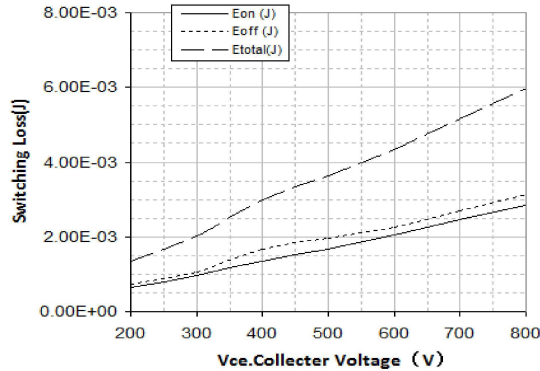
Switching Loss vs. $R_g(175^\circ\text{C})$

$V_{GE}=15\text{V}, V_{CE}=600\text{V}, I_C=40\text{A}$



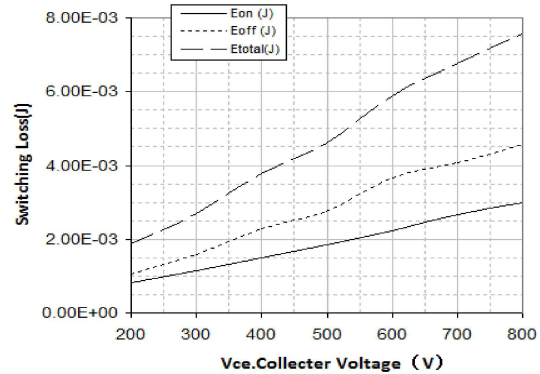
Switching Loss vs. $V_{CE}(25^\circ\text{C})$

$V_{GE}=15\text{V}, I_C=40\text{A}, R_g=12\Omega$



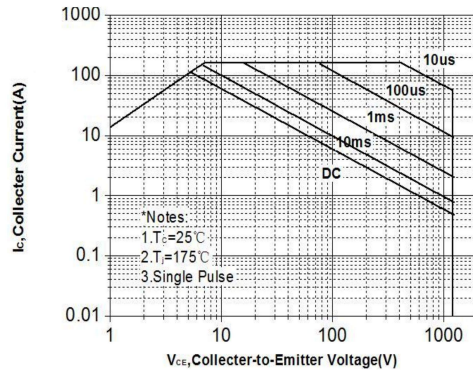
Switching Loss vs. $V_{CE}(175^\circ\text{C})$

$V_{GE}=15\text{V}, I_C=40\text{A}, R_g=12\Omega$



Forward Bias SOA

$T_c=25^\circ\text{C}, V_{GE}=15\text{V}, T_j \leq 175^\circ\text{C}$



Normalized Maximum Transient Thermal Impedance for IGBT(RJA)

